

<b>Notice of References Cited</b>	Application/Control No. 10/583,030	Applicant(s)/Patent Under Reexamination LEFEBVRE ET AL.	
	Examiner Robert H. Muromoto, Jr.	Art Unit 3765	Page 1 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,404,889 A	09-1983	Miguel, Anthony S.	89/36.02
*	B	US-4,443,506 A	04-1984	Schmolmann et al.	428/102
*	C	US-4,648,136 A	03-1987	Higuchi, Susumu	2/2.5
*	D	US-4,737,402 A	04-1988	Harpell et al.	442/187
*	E	US-5,070,540 A	12-1991	Bettcher et al.	2/2.5
*	F	US-5,200,256 A	04-1993	Dunbar, C. R.	428/212
*	G	US-5,472,769 A	12-1995	Goerz et al.	428/138
*	H	US-5,563,364 A	10-1996	Alhamad, Shaikh G. M. Y.	102/303
*	I	US-5,622,771 A	04-1997	Chiou et al.	428/219
*	J	US-5,697,098 A	12-1997	Miguel-Bettencourt et al.	2/2.5
*	K	US-5,822,791 A	10-1998	Baris, Robert P.	2/2.5
*	L	US-5,903,920 A	05-1999	Granqvist, Kaj	2/2.5
*	M	US-5,950,237 A	09-1999	Micheron et al.	2/69

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/583,030	Applicant(s)/Patent Under Reexamination LEFEBVRE ET AL.	
	Examiner Robert H. Muromoto, Jr.	Art Unit 3765	Page 2 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,103,646 A	08-2000	Chiou, Minshon J	442/244
*	B	US-6,133,169 A	10-2000	Chiou et al.	442/234
*	C	US-6,321,655 B1	11-2001	Tota et al.	102/302
*	D	US-6,332,401 B1	12-2001	Tota et al.	102/303
*	E	US-6,363,527 B1	04-2002	Biermann et al.	2/2.5
*	F	US-6,534,426 B1	03-2003	Chiou, Minshon J.	442/203
*	G	US-6,684,404 B2	02-2004	Bachner et al.	2/2.5
*	H	US-6,737,368 B2	05-2004	Chiou, Minshon J.	442/134
*	I	US-6,825,137 B2	11-2004	Fu et al.	442/135
*	J	US-6,845,513 B2	01-2005	Field et al.	2/2.5
*	K	US-6,854,296 B1	02-2005	Miller, III, Robert A.	66/190
*	L	US-7,080,411 B2	07-2006	Kerr, Andrew Robert England	2/2.5
*	M	US-7,120,938 B2	10-2006	Ichigaya, Hiroshi	2/272

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

**Notice of References Cited**

Application/Control No.

10/583,030

Applicant(s)/Patent Under  
Reexamination  
LEFEBVRE ET AL.

Examiner

Robert H. Muromoto, Jr.

Art Unit

3765

Page 3 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,288,326 B2	10-2007	Elzey et al.	428/593
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.